

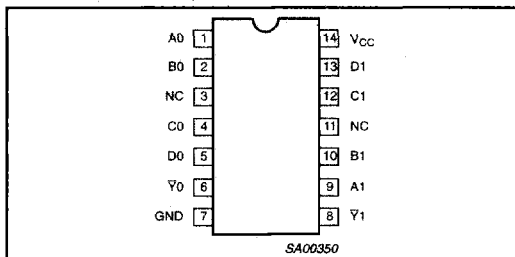
# 3.3V Dual 4-input NAND gate

74LVT20

## QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS $T_{amb} = 25^{\circ}\text{C};$ $GND = 0V$	TYPICAL	UNIT
$t_{PLH}$ $t_{PHL}$	Propagation delay $A_n, B_n, C_n, D_n$ to $\bar{Y}_n$	$C_L = 50\text{pF};$ $V_{CC} = 3.3V$	3.4 3.2	ns
$C_{IN}$	Input capacitance	$V_I = 0V$ or $3.0V$	3	pF
$I_{CC}$	Total supply current	Outputs Low; $V_{CC} = 3.6V$	0.5	mA

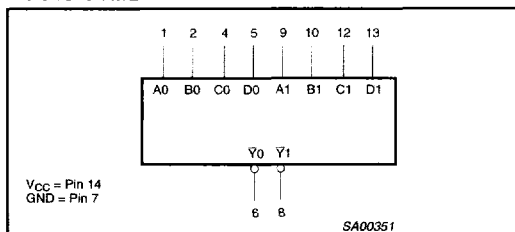
## PIN CONFIGURATION



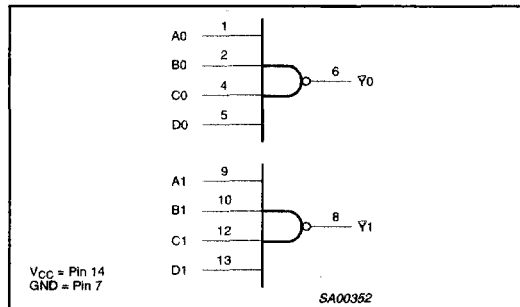
## PIN DESCRIPTION

PIN NUMBER	SYMBOL	NAME AND FUNCTION
1, 2, 4, 5, 9, 10, 12, 13	$A_n, B_n, C_n, D_n$	Data inputs
6, 8	$\bar{Y}_n$	Data outputs
7	GND	Ground (0V)
14	$V_{CC}$	Positive supply voltage

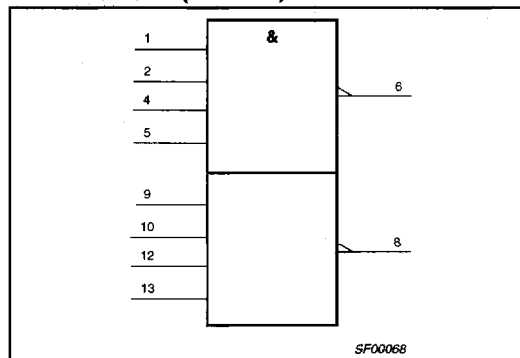
## LOGIC SYMBOL



## LOGIC DIAGRAM



## LOGIC SYMBOL (IEEE/IEC)



## FUNCTION TABLE

INPUTS				OUTPUT
$D_{na}$	$D_{nb}$	$D_{nc}$	$D_{nd}$	$\bar{Q}_n$
L	X	X	X	H
X	L	X	X	H
X	X	L	X	H
X	X	X	L	H
H	H	H	H	L

### NOTES:

- H = High voltage level
- L = Low voltage level
- X = Don't care

## ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
14-Pin Plastic SO	-40°C to +85°C	74LVT20 D	74LVT20 D	SOT108-1
14-Pin Plastic SSOP	-40°C to +85°C	74LVT20 DB	74LVT20 DB	SOT337-1
14-Pin Plastic TSSOP	-40°C to +85°C	74LVT20 PW	74LVT20PW DH	SOT402-1

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**ABSOLUTE MAXIMUM RATINGS<sup>1, 2</sup>**

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
$V_{CC}$	DC supply voltage		-0.5 to +4.6	V
$I_{IK}$	DC input diode current	$V_I < 0$	-50	mA
$V_I$	DC input voltage <sup>3</sup>		-0.5 to +7.0	V
$I_{OK}$	DC output diode current	$V_O < 0$	-50	mA
$V_{OUT}$	DC output voltage <sup>3</sup>	Output in Off or High state	-0.5 to +7.0	V
$I_{OUT}$	DC output current	Output in High state	-32	mA
		Output in Low state	64	
$T_{stg}$	Storage temperature range		-65 to 150	°C

**NOTES:**

- Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.
- The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

**RECOMMENDED OPERATING CONDITIONS**

SYMBOL	PARAMETER	LIMITS		UNIT
		MIN	MAX	
$V_{CC}$	DC supply voltage	2.7	3.6	V
$V_I$	Input voltage	0	5.5	V
$V_{IH}$	High-level input voltage	2.0		V
$V_{IL}$	Low-level input voltage		0.8	V
$I_{OH}$	High-level output current		-20	mA
$I_{OL}$	Low-level output current		32	mA
	Low-level output current; current duty cycle $\leq 50\%$ , $f \geq 1\text{kHz}$		48	
$T_{amb}$	Operating free-air temperature range	-40	+85	°C

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## DC ELECTRICAL CHARACTERISTICS

Over recommended operating conditions  
 Voltages are referenced to GND (ground = 0V)

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			UNIT
			Temp = -40°C to +85°C			
			MIN	TYP <sup>1</sup>	MAX	
$V_{IK}$	Input clamp voltage	$V_{CC} = 2.7V; I_{IK} = -18mA$			-1.2	V
$V_{OH}$	High-level output voltage	$V_{CC} = 2.7$ to $3.6V; I_{OH} = -100\mu A$	$V_{CC}-0.2$			V
		$V_{CC} = 2.7V; I_{OH} = -8mA$	2.4			
		$V_{CC} = 3.0V; I_{OH} = -20mA$	2.0			
$V_{OL}$	Low-level output voltage	$V_{CC} = 2.7V; I_{OL} = 100\mu A$			0.2	V
		$V_{CC} = 2.7V; I_{OL} = 24mA$			0.5	
		$V_{CC} = 3.0V; I_{OL} = 32mA$			0.5	
$I_I$	Input leakage current	$V_{CC} = 0$ or $3.6V; V_I = 5.5V$			10	$\mu A$
		$V_{CC} = 3.6V; V_I = V_{CC}$ or GND			$\pm 1$	
$I_{OFF}$	Output off current	$V_{CC} = 0V; V_I$ or $V_O = 0$ to $4.5V$			$\pm 100$	$\mu A$
$I_{CCH}$	Quiescent supply current	$V_{CC} = 3.6V$ ; Outputs High, $V_I = GND$ or $V_{CC}, I_O = 0$			0.02	mA
$I_{CCL}$		$V_{CC} = 3.6V$ ; Outputs Low, $V_I = GND$ or $V_{CC}, I_O = 0$		0.5	1.2	
$\Delta I_{CC}$	Additional supply current per input pin <sup>2</sup>	$V_{CC} = 3V$ to $3.6V$ ; One input at $V_{CC}-0.6V$ , Other inputs at $V_{CC}$ or GND			0.2	$\mu A$
$C_I$	Input capacitance	$V_I = 3V$ or $0$		3		pF

**NOTES:**

- All typical values are at  $V_{CC} = 3.3V$  and  $T_{amb} = 25^\circ C$ .
- This is the increase in supply current for each input at the specified voltage level other than  $V_{CC}$  or GND.

## AC CHARACTERISTICS

GND = 0V;  $t_R = t_F = 2.5ns$ ;  $C_L = 50pF, R_L = 500\Omega; T_{amb} = -40^\circ C$  to  $+85^\circ C$ .

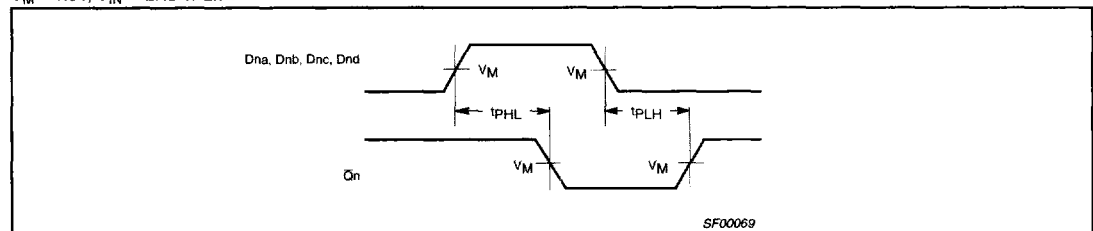
SYMBOL	PARAMETER	WAVEFORM	LIMITS				UNIT
			$V_{CC} = 3.3V \pm 0.3V$			$V_{CC} = 2.7V$	
			MIN	TYP <sup>1</sup>	MAX	MAX	
$t_{PLH}$ $t_{PHL}$	Propagation delay An, Bn, Cn, Dn to $\bar{Y}_n$	1	1.0 1.0	3.4 3.2	5.4 4.4	6.4 4.3	ns

**NOTE:**

- All typical values are at  $V_{CC} = 3.3V$  and  $T_{amb} = 25^\circ C$ .

## AC WAVEFORMS

$V_M = 1.5V, V_{IN} = GND$  to  $2.7V$

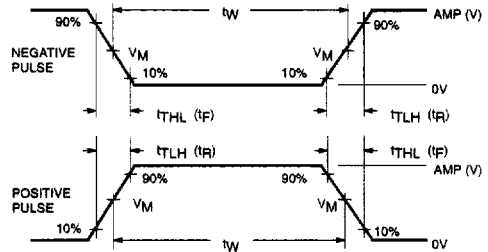
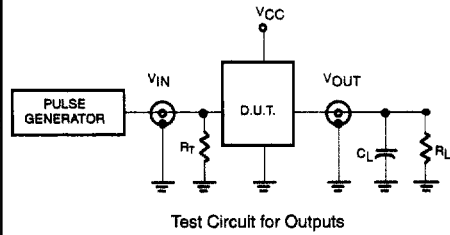


Waveform 1. Propagation Delay for Inverting Outputs

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## TEST CIRCUIT AND WAVEFORMS



$V_M = 1.5V$   
Input Pulse Definition

### DEFINITIONS

$R_L$  = Load resistor; see AC CHARACTERISTICS for value.

$C_L$  = Load capacitance includes jig and probe capacitance; see AC CHARACTERISTICS for value.

$R_T$  = Termination resistance should be equal to  $Z_{OUT}$  of pulse generators.

FAMILY	INPUT PULSE REQUIREMENTS				
	Amplitude	Rep. Rate	$t_W$	$t_R$	$t_F$
74LVT	2.7V	$\leq 10\text{MHz}$	500ns	$\leq 2.5\text{ns}$	$\leq 2.5\text{ns}$

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